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1 Block diagram and pin description

Figure 1. Block diagram

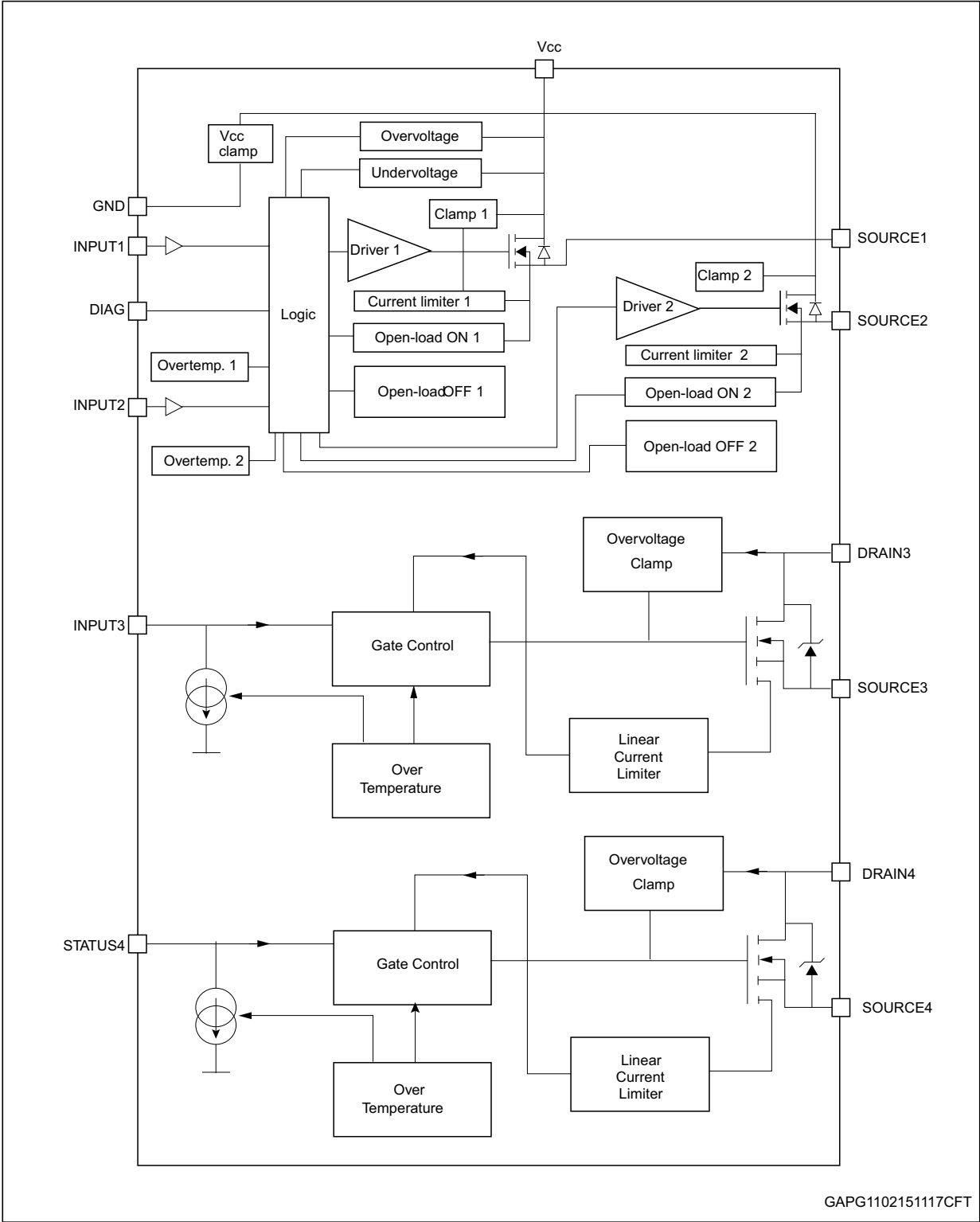
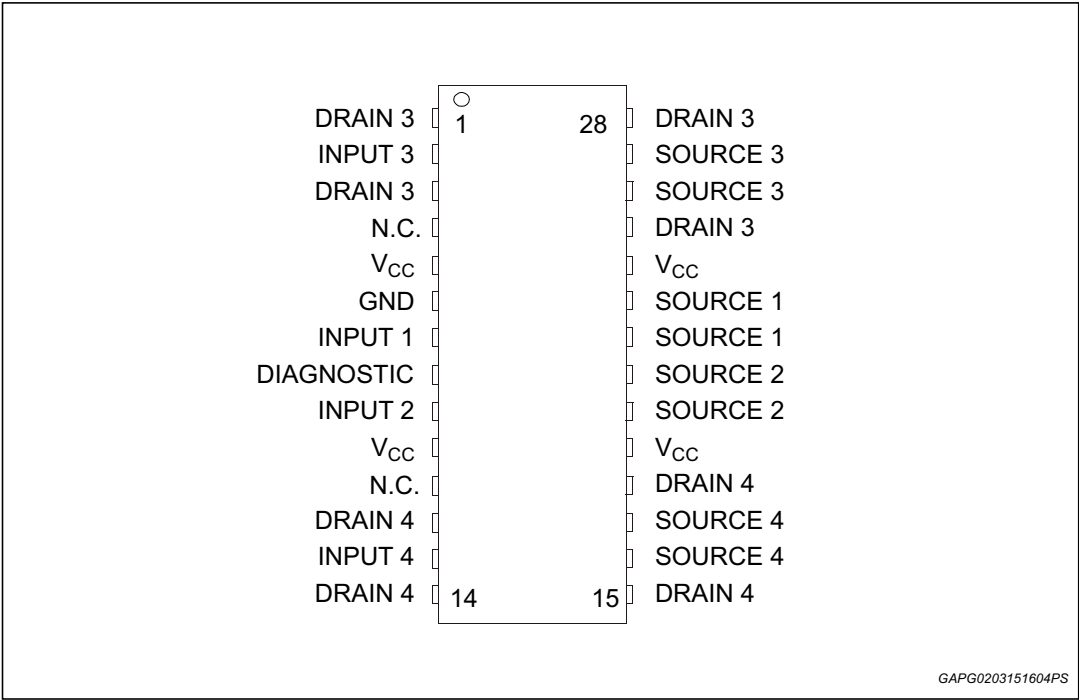


Table 2. Pin definition and function

No	Name	Function
1, 3, 25, 28	DRAIN 3	Drain of switch 3 (low-side switch)
2	INPUT 3	Input of switch 3 (low-side switch)
4, 11	N.C.	Not connected
5, 10, 19, 24	V _{CC}	Drain of switches 1 and 2 (high-side switches) and power supply voltage
6	GND	Ground of switches 1 and 2 (high-side switches)
7	INPUT 1	Input of switch 1 (high-side switches)
8	DIAGNOSTIC	Diagnostic of switches 1 and 2 (high-side switches)
9	INPUT 2	Input of switch 2 (high-side switch)
12, 14, 15, 18	DRAIN 4	Drain of switch 4 (low-side switch)
13	INPUT 4	Input of switch 4 (low-side switch)
16, 17	SOURCE 4	Source of switch 4 (low-side switch)
20, 21	SOURCE 2	Source of switch 2 (high-side switch)
22, 23	SOURCE 1	Source of switch 1 (high-side switch)
26, 27	SOURCE 3	Source of switch 3 (low-side switch)

Figure 2. Connection diagram



2 Electrical specifications

2.1 Thermal data

Table 3. Thermal data

Symbol	Parameter	Value Max (°C/W)
$R_{thj-case}$	Thermal resistance junction-case (high side switch)	20
$R_{thj-case}$	Thermal resistance junction-case (low side switch)	20
$R_{thj-amb}$	Thermal resistance junction-ambient (with 6 cm ² of Cu heat sink)	See Figure 49

2.2 Absolute maximum ratings

Table 4. Dual high side switch

Symbol	Parameter	Value	Unit
V_{CC}	DC supply voltage	41	V
$-V_{CC}$	Reverse DC supply voltage	-0.3	V
$-I_{GND}$	DC reverse ground pin current	-200	mA
I_{OUT}	DC output current	Internally limited	A
$-I_{OUT}$	Reverse DC output current	-6	A
I_{IN}	DC input current	±10	mA
I_{STAT}	DC status current	±10	mA
V_{ESD}	Electrostatic discharge (human body model: R = 1.5 kΩ; C = 100 pF)		
	– Input	4000	V
	– Status	4000	V
	– Output	5000	V
	– V _{CC}	5000	V
P_{tot}	Power dissipation (T _C = 25°C)	6	W
T_j	Junction operating temperature	Internally limited	°C
T_C	Case operating temperature	-40 to 150	°C
T_{stg}	Storage temperature	-55 to 150	°C

Table 5. Low side switch

Symbol	Parameter	Value	Unit
V_{DS}	Drain source voltage (V _{IN} = 0 V)	Internally clamped	V
V_{IN}	Input voltage	Internally clamped	V
I_{IN}	Input current	±20	mA

Table 5. Low side switch (continued)

Symbol	Parameter	Value	Unit
$R_{IN\ MIN}$	Minimum input series impedance	150	Ω
I_D	Drain current	Internally limited	A
I_R	Reverse DC output current	-10.5	A
V_{ESD1}	Electrostatic discharge ($R = 1.5\ k\Omega$, $C = 100\ pF$)	4000	V
V_{ESD2}	Electrostatic discharge on output pin only (human body model: $R = 330\ \Omega$, $C = 150\ pF$)	5000	V
P_{tot}	Power dissipation ($T_C = 25^\circ C$)	6	W
T_j	Operating junction temperature	Internally limited	$^\circ C$
T_C	Case operating temperature	Internally limited	$^\circ C$
T_{stg}	Storage temperature	-55 to 150	$^\circ C$

2.3 Electrical characteristics for dual high side switch

8 V < V_{CC} < 36 V; $-40^\circ C < T_j < 150^\circ C$, unless otherwise specified.

Table 6. Power outputs (per each channel)

Symbol	Parameter	Test conditions	Min	Typ	Max	Unit
$V_{CC}^{(1)}$	Operating supply voltage		5.5	13	36	V
$V_{USD}^{(1)}$	Undervoltage shutdown		3	4	5.5	V
$V_{OV}^{(1)}$	Overvoltage shutdown		36	-	-	V
R_{ON}	On-state resistance	$I_{OUT} = 1\ A$; $T_j = 25^\circ C$			160	m Ω
		$I_{OUT} = 1\ A$; $V_{CC} > 8\ V$			320	m Ω
$I_S^{(1)}$	Supply current	Off-state; $V_{CC} = 13\ V$; $V_{IN} = V_{OUT} = 0\ V$		12	40	μA
		Off-state; $V_{CC} = 13\ V$; $V_{IN} = V_{OUT} = 0\ V$; $T_j = 25^\circ C$		12	25	μA
		On-state; $V_{CC} = 13\ V$; $V_{IN} = 5\ V$; $I_{OUT} = 0\ V$		5	7	mA
$I_{L(off1)}$	Off-state output current	$V_{IN} = V_{OUT} = 0\ V$	0		50	μA
$I_{L(off2)}$	Off-state output current	$V_{IN} = 0\ V$; $V_{OUT} = 3.5\ V$	-75		0	μA
$I_{L(off3)}$	Off-state output current	$V_{IN} = V_{OUT} = 0\ V$; $V_{CC} = 13\ V$; $T_j = 125^\circ C$			5	μA
$I_{L(off4)}$	Off-state output current	$V_{IN} = V_{OUT} = 0\ V$; $V_{CC} = 13\ V$; $T_j = 25^\circ C$			3	μA

1. Per device.

Table 7. Switching (per each channel) ($V_{CC} = 13 \text{ V}$)

Symbol	Parameter	Test conditions	Min	Typ	Max	Unit
$t_{d(on)}$	Turn-on delay time	$R_L = 13 \Omega$ from V_{IN} rising edge to $V_{OUT} = 1.3 \text{ V}$	—	30	—	μs
$t_{d(off)}$	Turn-off delay time	$R_L = 13 \Omega$ from V_{IN} falling edge to $V_{OUT} = 11.7 \text{ V}$	—	30	—	μs
$dV_{OUT}/dt_{(on)}$	Turn-on voltage slope	$R_L = 13 \Omega$ from $V_{OUT} = 1.3 \text{ V}$ to $V_{OUT} = 10.4 \text{ V}$	—	(1)	—	$\text{V}/\mu\text{s}$
$dV_{OUT}/dt_{(off)}$	Turn-off voltage slope	$R_L = 13 \Omega$ from $V_{OUT} = 11.7 \text{ V}$ to $V_{OUT} = 1.3 \text{ V}$	—	(1)	—	$\text{V}/\mu\text{s}$

1. See relative diagram

Table 8. Logic input (per each channel)

Symbol	Parameter	Test conditions	Min	Typ	Max	Unit
V_{IL}	Input low level				1.25	V
I_{IL}	Low level input current	$V_{IN} = 1.25 \text{ V}$	1			μA
V_{IH}	Input high level		3.25			V
I_{IH}	High level input current	$V_{IN} = 3.25 \text{ V}$			10	μA
$V_{I(hyst)}$	Input hysteresis voltage		0.5			V
V_{ICL}	Input clamp voltage	$I_{IN} = 1 \text{ mA}$	6	6.8	8	V
		$I_{IN} = -1 \text{ mA}$		-0.7		V

Table 9. Status pin (per each channel)

Symbol	Parameter	Test conditions	Min	Typ	Max	Unit
V_{STAT}	Status low output voltage	$I_{STAT} = 1.6 \text{ mA}$			0.5	V
I_{LSTAT}	Status leakage current	Normal operation; $V_{STAT} = 5 \text{ V}$			10	μA
C_{STAT}	Status pin input capacitance	Normal operation; $V_{STAT} = 5 \text{ V}$			100	pF
V_{SCL}	Status clamp voltage	$I_{STAT} = 1 \text{ mA}$	6	6.8	8	V
		$I_{STAT} = -1 \text{ mA}$		-0.7		V

Table 10. Protections (per each channel)

Symbol	Parameter	Test conditions	Min	Typ	Max	Unit
T_{TSD}	Shutdown temperature		150	175	200	$^{\circ}\text{C}$
T_R	Reset temperature		135	-		$^{\circ}\text{C}$
T_{hyst}	Thermal hysteresis		7	15		$^{\circ}\text{C}$
t_{SDL}	Status delay in overload conditions	$T_j > T_{TSD}$			20	μs

Table 10. Protections (per each channel) (continued)

Symbol	Parameter	Test conditions	Min	Typ	Max	Unit
I_{lim}	Current limitation		7	10	13	A
		$T_j = 125\text{ °C}$	8		13	A
		$5.5\text{ V} < V_{CC} < 36\text{ V}$			13	A
V_{demag}	Turn-off output clamp voltage	$I_{OUT} = 1\text{ A}$; $L = 6\text{ mH}$	$V_{CC} - 41$	$V_{CC} - 48$	$V_{CC} - 55$	V

Note: To ensure long term reliability under heavy overload or short circuit conditions, protection and related diagnostic signals must be used together with a proper software strategy. If the device is subjected to abnormal conditions, this software must limit the duration and number of activation cycles.

Table 11. Openload detection (per each channel)

Symbol	Parameter	Test conditions	Min	Typ	Max	Unit
I_{OL}	Openload on-state detection threshold	$V_{IN} = 5\text{ V}$	20	40	80	mA
$t_{DOL(on)}$	Openload on-state detection delay	$I_{OUT} = 0\text{ A}$			200	μs
V_{OL}	Openload off-state voltage detection threshold	$V_{IN} = 0\text{ V}$	1.5	2.5	3.5	V
$t_{DOL(off)}$	Openload detection delay at turn-off				1000	μs

2.4 Electrical characteristics for low side switches

$-40\text{ °C} < T_j < 150\text{ °C}$, unless otherwise specified.

Table 12. Off-state

Symbol	Parameter	Test conditions	Min	Typ	Max	Unit
V_{CLAMP}	Drain source clamp voltage	$V_{IN} = 0\text{ V}$; $I_D = 3.5\text{ A}$	40	45	55	V
V_{CLTH}	Drain source clamp threshold voltage	$V_{IN} = 0\text{ V}$; $I_D = 2\text{ mA}$	36			V
V_{INTH}	Input threshold voltage	$V_{DS} = V_{IN}$; $I_D = 1\text{ mA}$	0.5		2.5	V
I_{ISS}	Supply current from input pin	$V_{DS} = 0\text{ V}$; $V_{IN} = 5\text{ V}$		100	150	μA
V_{INCL}	Input-source clamp voltage	$I_{IN} = 1\text{ mA}$	6	6.8	8	V
		$I_{IN} = -1\text{ mA}$	-1.0		-0.3	V
I_{DSS}	Zero input voltage drain current ($V_{IN} = 0\text{ V}$)	$V_{DS} = 13\text{ V}$; $V_{IN} = 0\text{ V}$; $T_j = 25\text{ °C}$			30	μA
		$V_{DS} = 25\text{ V}$; $V_{IN} = 0\text{ V}$			75	μA

Table 13. On-state

Symbol	Parameter	Test conditions	Min	Typ	Max	Unit
$R_{DS(on)}$	Static drain source on resistance	$V_{IN} = 5\text{ V}; I_D = 3.5\text{ A}; T_J = 25^\circ\text{C}$	—	—	65	m Ω
		$V_{IN} = 5\text{ V}; I_D = 3.5\text{ A}$	—	—	130	m Ω

$T_J = 25^\circ\text{C}$, unless otherwise specified.

Table 14. Dynamic

Symbol	Parameter	Test conditions	Min	Typ	Max	Unit
$g_{fs}^{(1)}$	Forward trans conductance	$V_{DD} = 13\text{ V}; I_D = 3.5\text{ A}$	—	9	—	S
C_{OSS}	Output capacitance	$V_{DS} = 13\text{ V}; f = 1\text{ MHz}; V_{IN} = 0\text{ V}$	—	220	—	pF

1. Pulsed: Pulse duration = 300 μ s, duty cycle 1.5%

Table 15. Switching

Symbol	Parameter	Test conditions	Min	Typ	Max	Unit
$t_{d(on)}$	Turn-on delay time	$V_{DD} = 15\text{ V}; I_D = 3.5\text{ A}; V_{gen} = 5\text{ V};$ $R_{gen} = R_{IN\text{ MIN}} = 150\text{ }\Omega$	—	100	300	ns
t_r	Rise time		—	470	1500	ns
$t_{d(off)}$	Turn-off delay time		—	500	1500	ns
t_f	Fall time		—	350	1000	ns
$t_{d(on)}$	Turn-on delay time	$V_{DD} = 15\text{ V}; I_D = 3.5\text{ A}; V_{gen} = 5\text{ V};$ $R_{gen} = 2.2\text{ K}\Omega$	—	0.75	2.3	μ s
t_r	Rise time		—	4.6	14	μ s
$t_{d(off)}$	Turn-off delay time		—	5.4	16	μ s
t_f	Fall time		—	3.6	11	μ s
$(di/dt)_{on}$	Turn-on current slope	$V_{DD} = 15\text{ V}; I_D = 3.5\text{ A}; V_{gen} = 5\text{ V};$ $R_{gen} = R_{IN\text{ MIN}} = 150\text{ }\Omega$	—	6.5		A/ μ s
Q_i	Total input charge	$V_{DD} = 12\text{ V}; I_D = 3.5\text{ A}; V_{IN} = 5\text{ V};$ $I_{gen} = 2.13\text{ mA}$	—	18		nC

Table 16. Source drain diode

Symbol	Parameter	Test conditions	Min	Typ	Max	Unit
$V_{SD}^{(1)}$	Forward on voltage	$I_{SD} = 3.5\text{ A}; V_{IN} = 0\text{ V}$	—	0.8	—	V
t_{rr}	Reverse recovery time	$I_{SD} = 3.5\text{ A}; di/dt = 20\text{ A}/\mu\text{s};$ $V_{DD} = 30\text{ V}; L = 200\text{ }\mu\text{H}$	—	220	—	ns
Q_{rr}	Reverse recovery charge		—	0.28	—	μ C
I_{RRM}	Reverse recovery current		—	2.5	—	A

1. Pulsed: Pulse duration = 300 μ s, duty cycle 1.5%

$-40^{\circ}\text{C} < T_j < 150^{\circ}\text{C}$, unless otherwise specified.

Table 17. Protections

Symbol	Parameter	Test conditions	Min	Typ	Max	Unit
I_{lim}	Drain current limit	$V_{IN} = 5\text{ V}; V_{DS} = 13\text{ V}$	6	9	12	A
		$V_{IN} = 5\text{ V}; V_{DS} = 13\text{ V}; T_j = 125^{\circ}\text{C}$	6.5		12	A
t_{dlim}	Step response current limit	$V_{IN} = 5\text{ V}; V_{DS} = 13\text{ V}$		4		μs
T_{jsh}	Over temperature shutdown		150	175		$^{\circ}\text{C}$
T_{jrs}	Over temperature reset		135			$^{\circ}\text{C}$
I_{gf}	Fault sink current	$V_{IN} = 5\text{ V}; V_{DS} = 13\text{ V}; T_j = T_{jsh}$		15		mA
E_{as}	Single pulse avalanche energy	Starting $T_j = 25^{\circ}\text{C}$; $V_{DD} = 24\text{ V}$; $V_{IN} = 5\text{ V}$; $R_{gen} = R_{IN\text{ MIN}} = 150\ \Omega$; $L = 24\text{ mH}$	200			mJ

2.5 Dual high-side switch timing data

Figure 3. Switching time waveforms

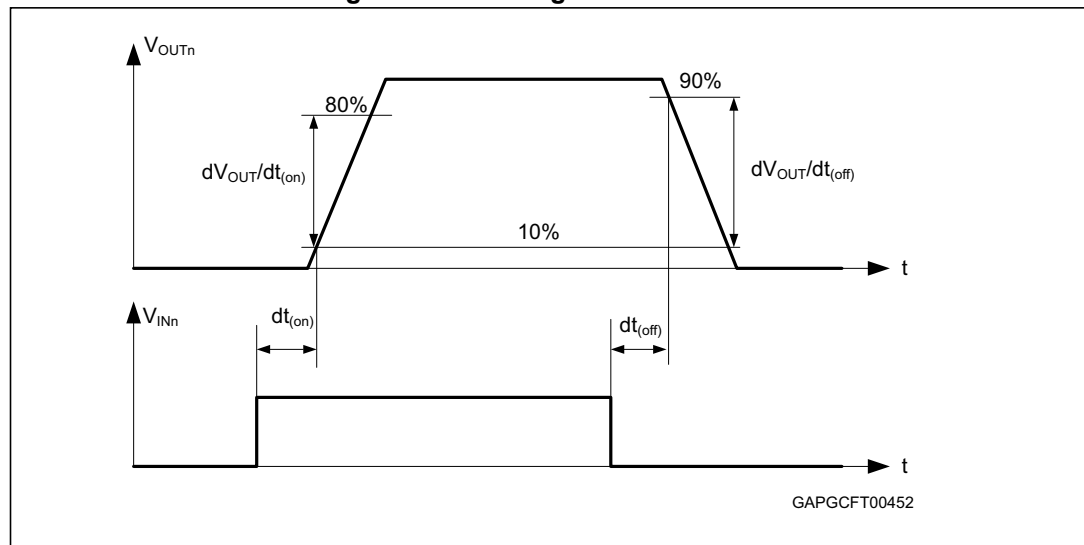


Table 18. Truth table

Conditions	Input	Output	Status
Normal operation	L	L	H
	H	H	H
Current limitation	L	L	H
	H	X	$(T_j < T_{TSD})\text{ H}$ $(T_j > T_{TSD})\text{ L}$
Over temperature	L	L	H
	H	L	L

Table 18. Truth table (continued)

Conditions	Input	Output	Status
Undervoltage	L	L	X
	H	L	X
Overvoltage	L	L	H
	H	L	H
Output voltage > V _{OL}	L	H	L
	H	H	H
Output current < I _{OL}	L	L	H
	H	H	L

Figure 4. Open-load status timing (with external pull-up)

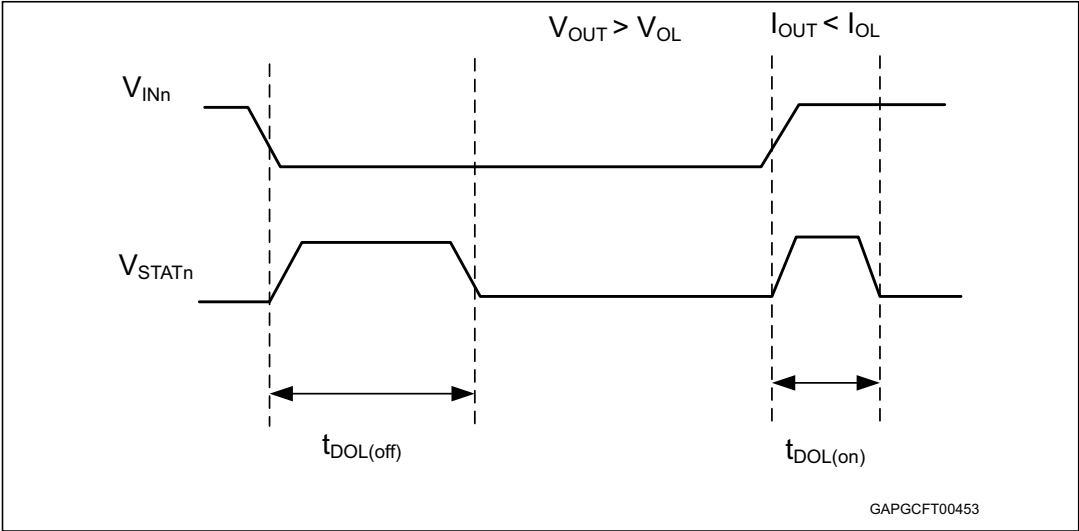
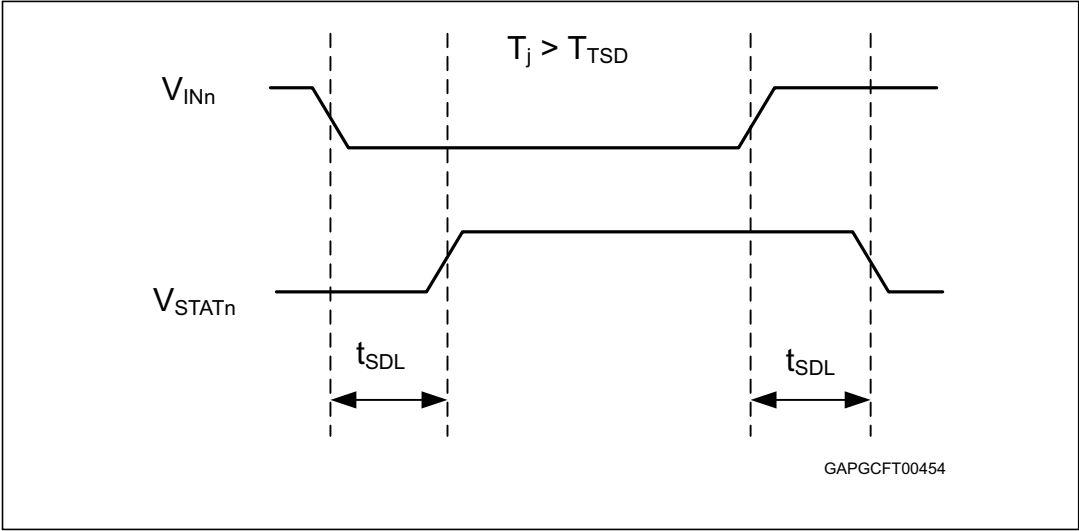


Figure 5. Over temperature status timing



2.6 Electrical characterization for dual high side switch

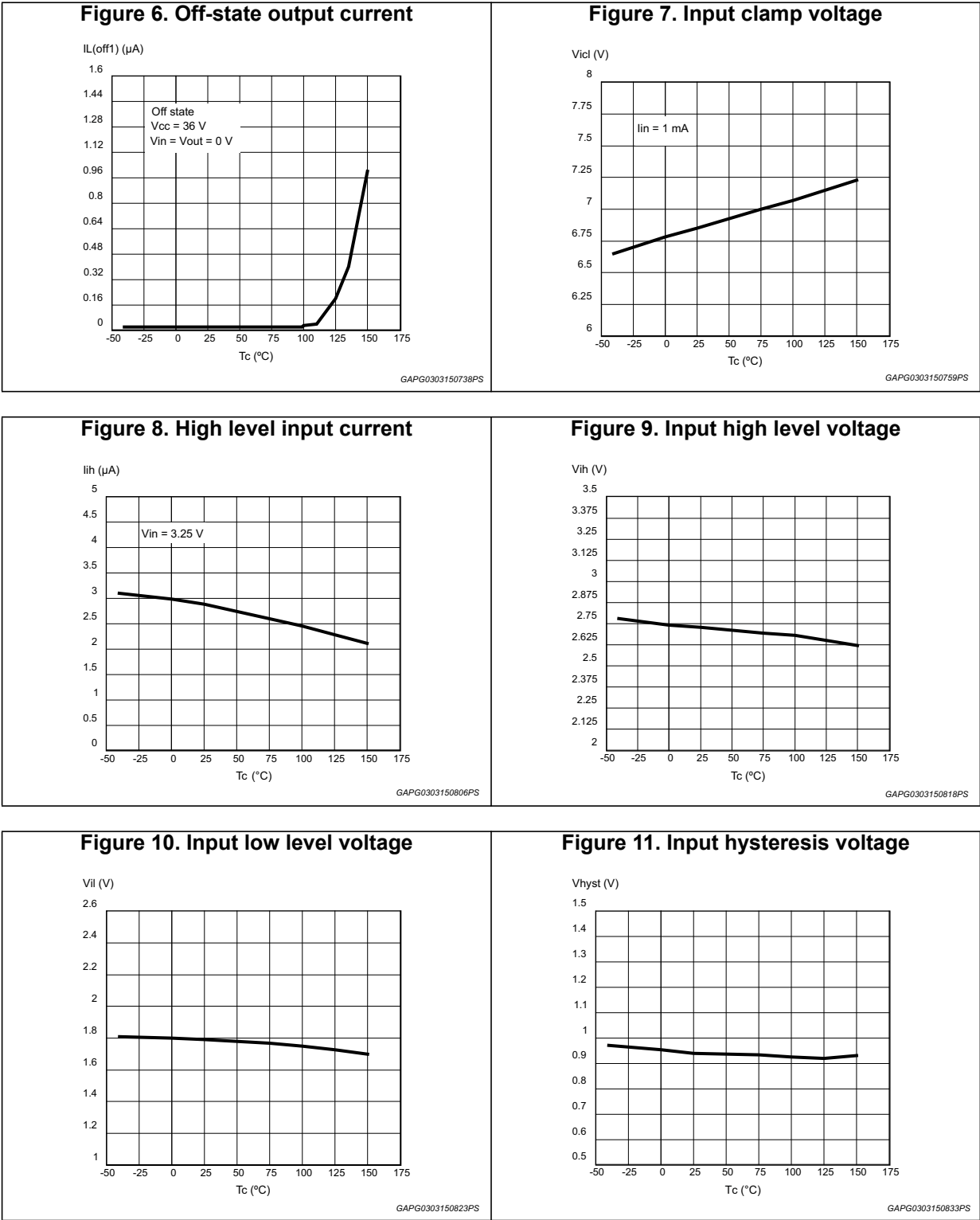
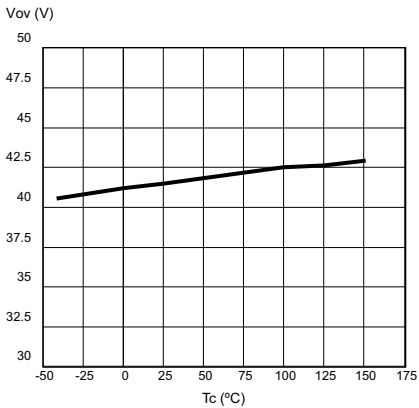
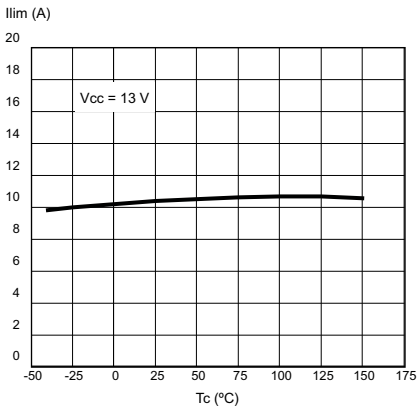


Figure 12. Overvoltage shutdown



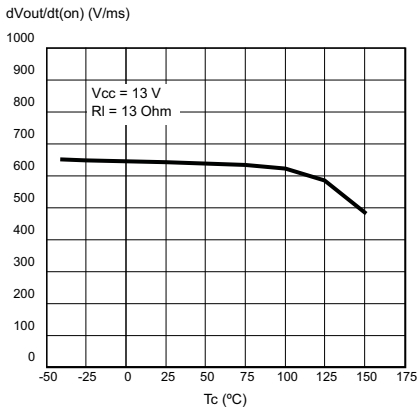
GAPG0303150903PS

Figure 13. I_{LIM} vs T_{case}



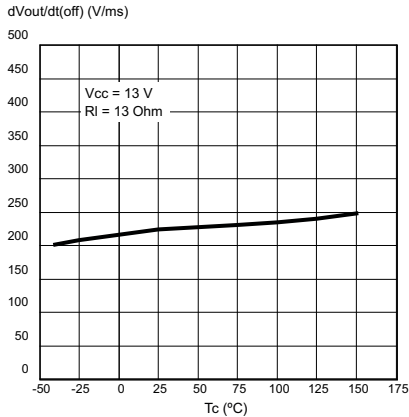
GAPG0303150910PS

Figure 14. Turn-on voltage slope



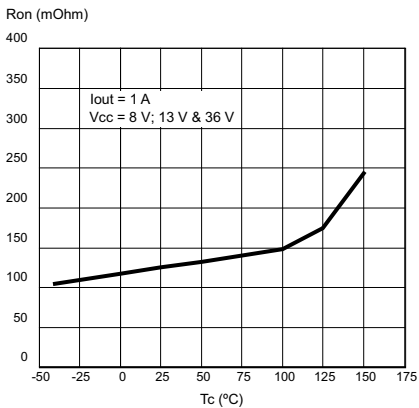
GAPG0303150915PS

Figure 15. Turn-off voltage slope



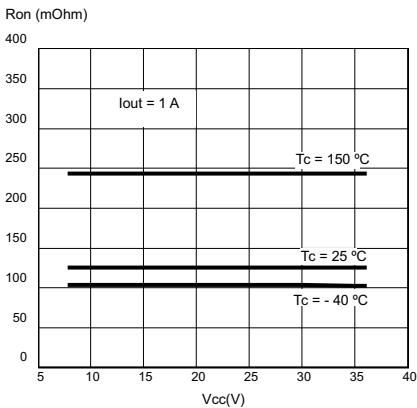
GAPG0303150920PS

Figure 16. On-state resistance vs T_{case}



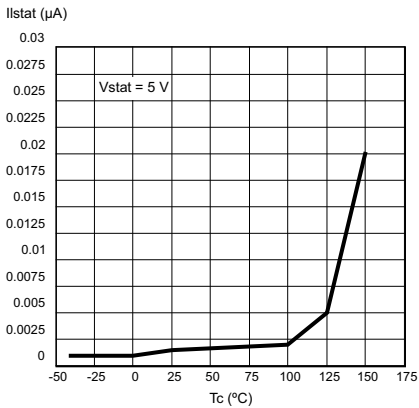
GAPG0303150932PS

Figure 17. On-state resistance vs V_{CC}



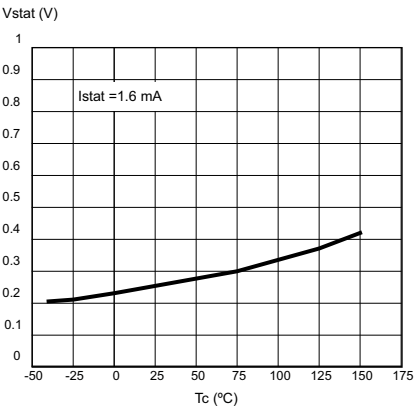
GAPG0303151145PS

Figure 18. Status leakage current



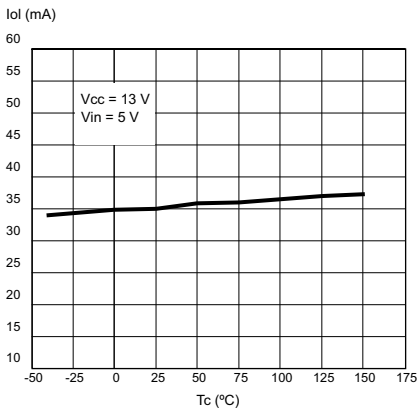
GAPG0303151151PS

Figure 19. Status low output voltage



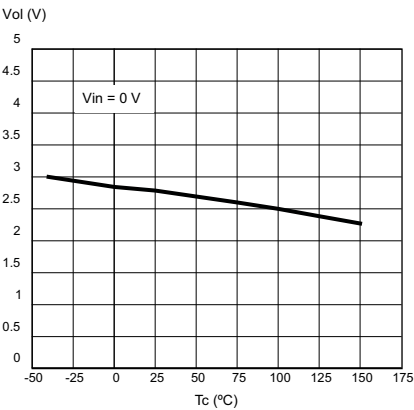
GAPG0303151155PS

Figure 20. Openload on-state detection threshold



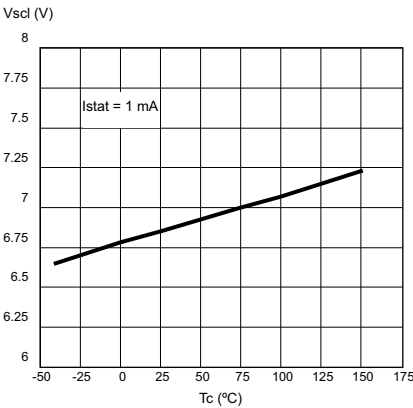
GAPG0303151201PS

Figure 21. Openload off-state voltage detection threshold



GAPG0303151206PS

Figure 22. Status clamp voltage



GAPG0303151227PS

2.7 Electrical characterization for low side switches

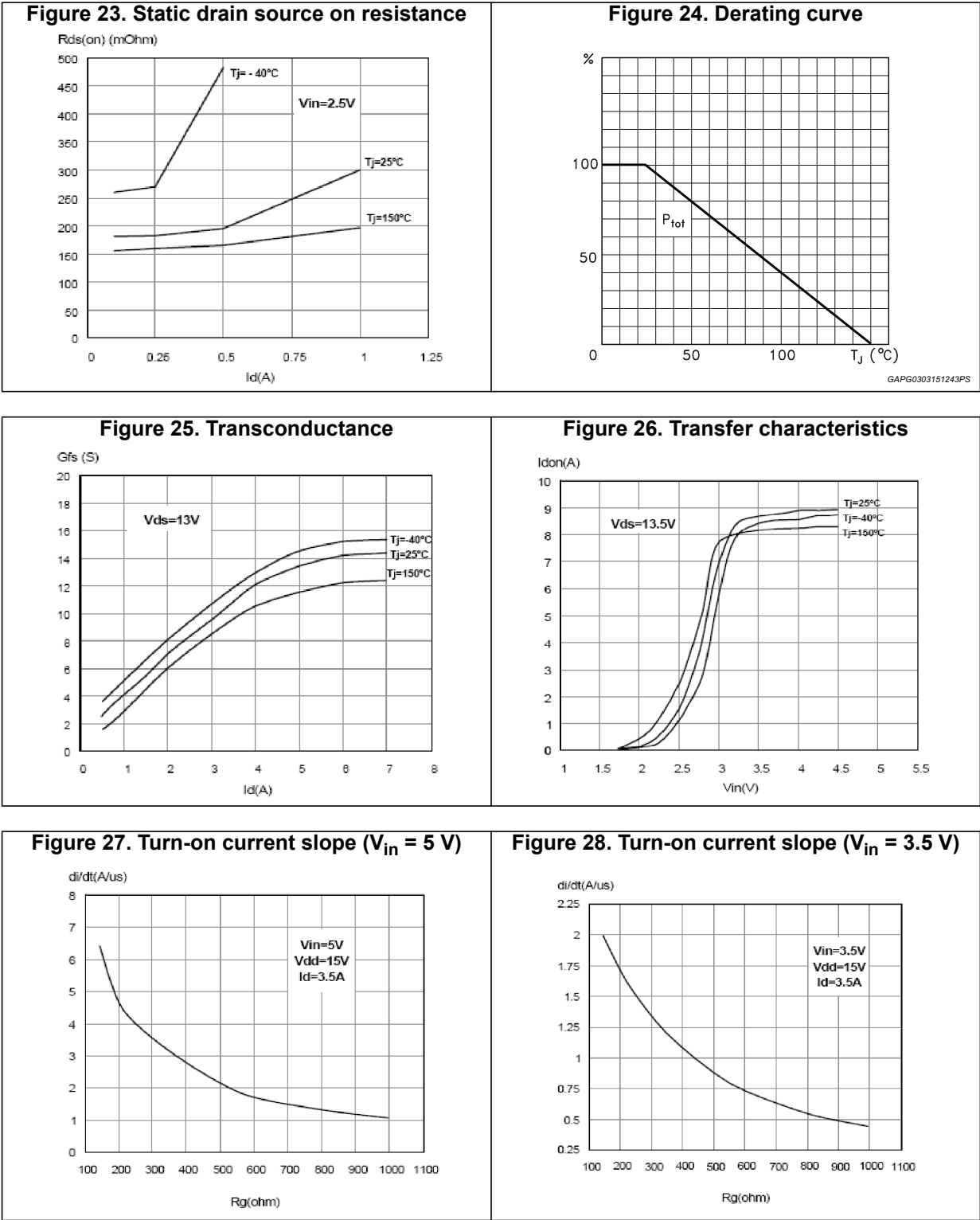


Figure 29. Input voltage vs input charge

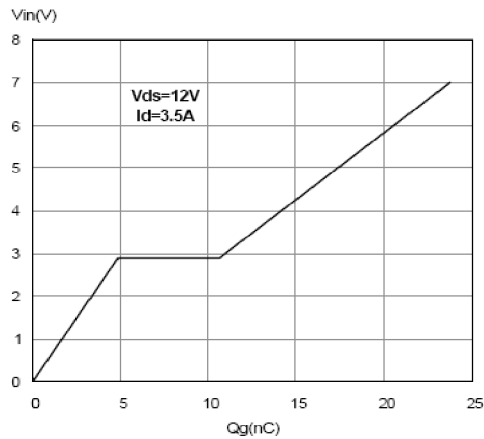


Figure 30. Capacitance variations

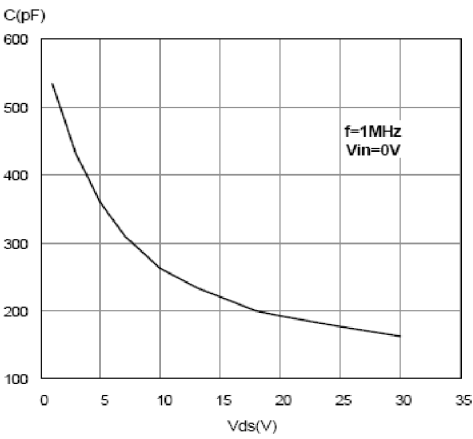


Figure 31. Switching time resistive load ($V_{in} = 5V$)

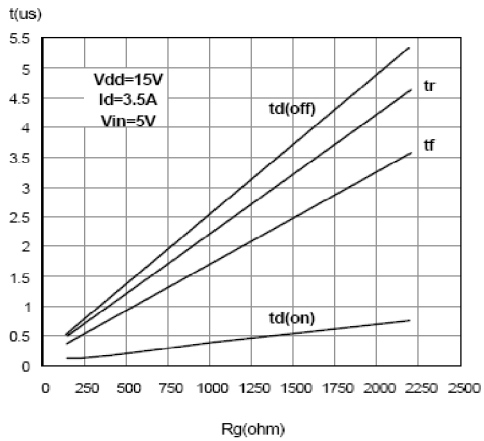


Figure 32. Switching time resistive load ($R_g = 10\text{ Ohm}$)

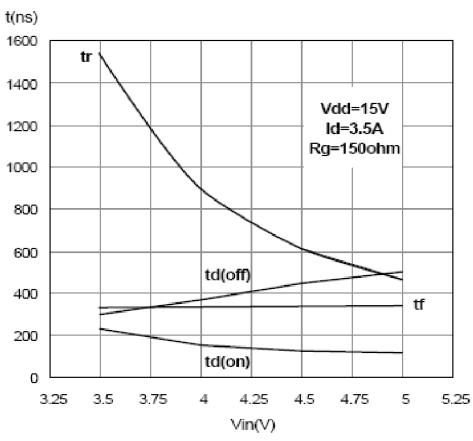


Figure 33. Output characteristics

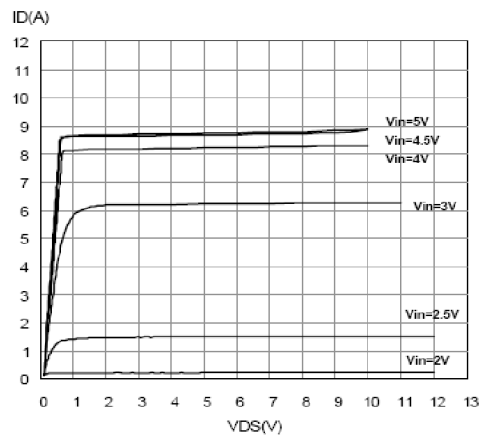


Figure 34. Step response current limit

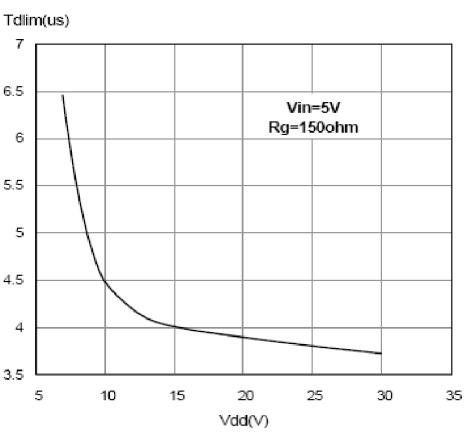


Figure 35. Source drain diode forward characteristics

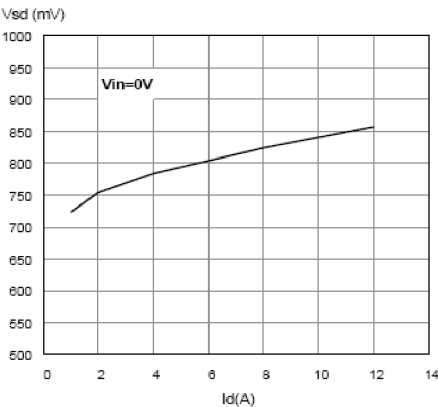


Figure 36. Static drain source on resistance vs I_d

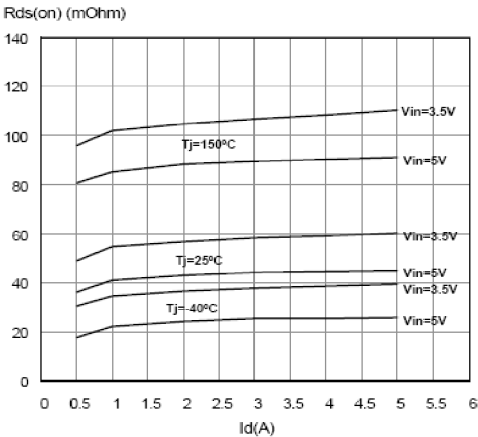


Figure 37. Static drain source on resistance vs input voltage ($I_d = 7\text{ A}$)

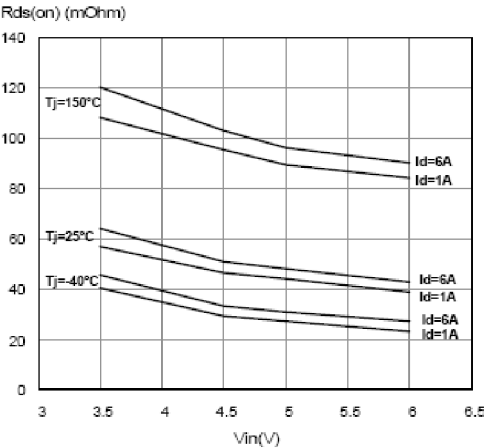


Figure 38. Static drain source on resistance vs input voltage

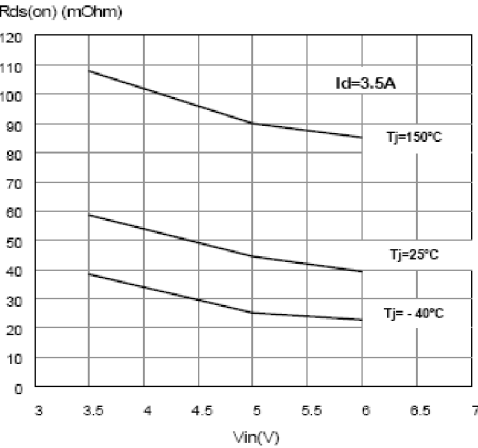


Figure 39. Normalized input threshold voltage vs temperature

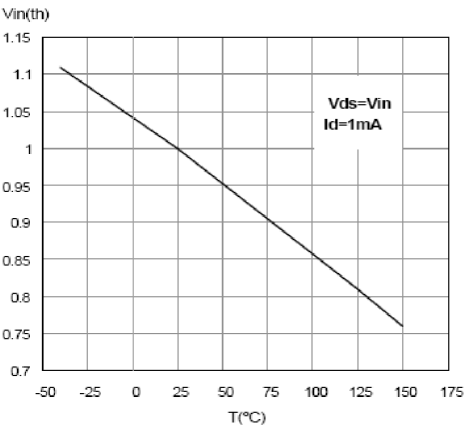
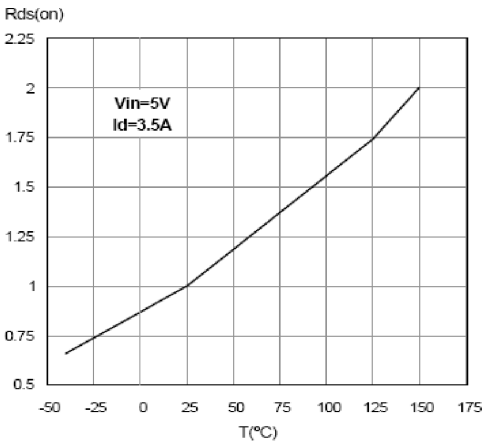
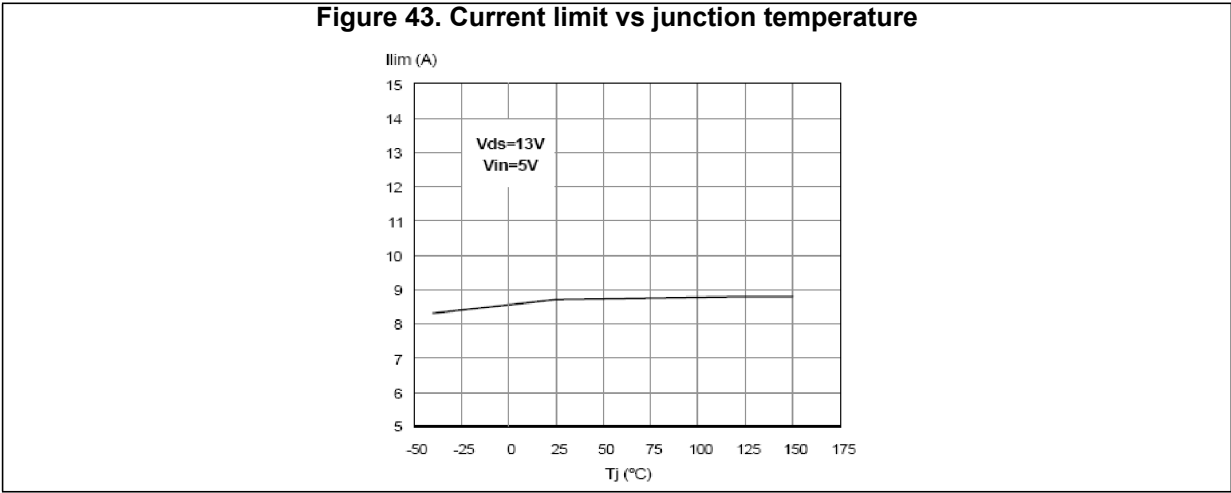
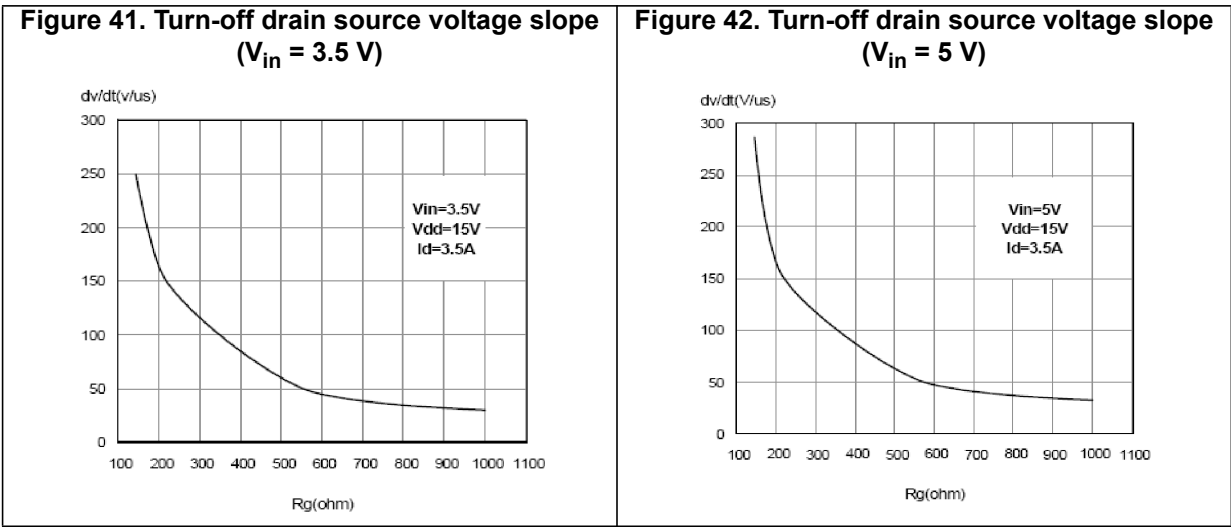


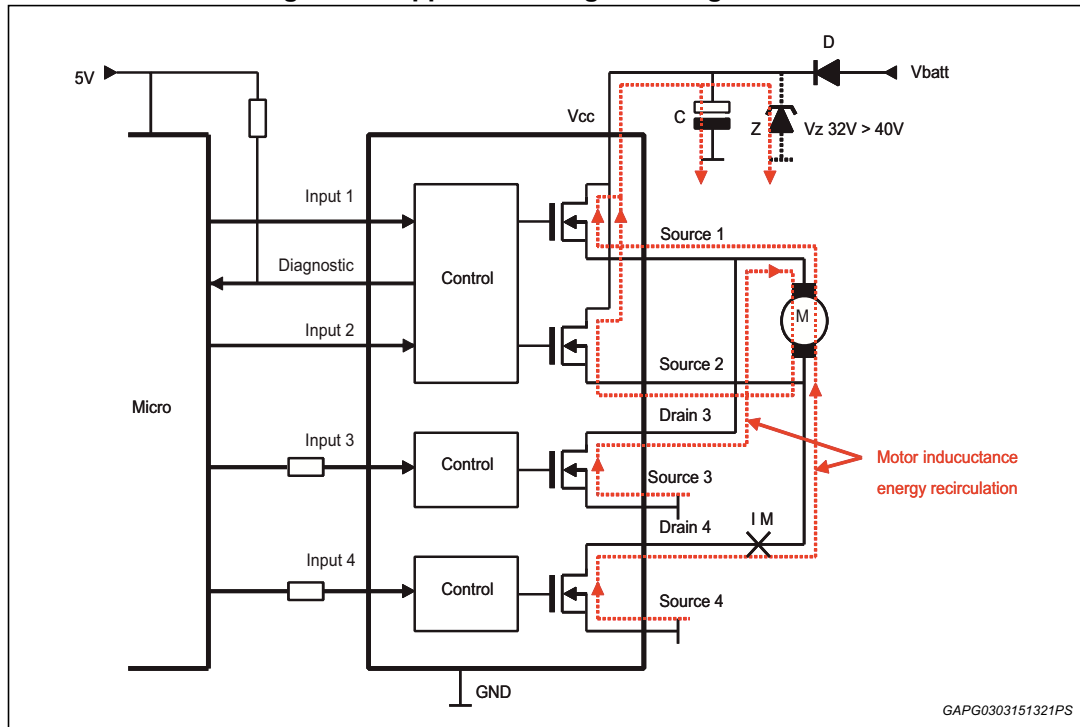
Figure 40. Normalized on resistance vs temperature





3 Application recommendations

Figure 44. Application diagram bridge drivers



Most motor bridge drivers use a reverse battery protection diode (D) inside the supply rail. This diode prevents a reverse current flow back to V_{BATT} in case the bridge becomes disabled via the logic inputs while motor inductance still carries energy. In order to prevent a hazardous overvoltage at circuit supply terminal (V_{CC}), a blocking capacitor (C) is needed to limit the voltage overshoot. As basic orientation, 50 μF per 1 A load current is recommended. As an alternative, a Zener protection (Z) is also suitable.

Even if a reverse polarity diode is not present, it is recommended to use a capacitor or Zener at V_{CC} because a similar problem appears in case the supply terminal of the module has intermittent electrical contact to the battery or gets disconnected while the motor is operating.

Figure 45. Recommended motor operation

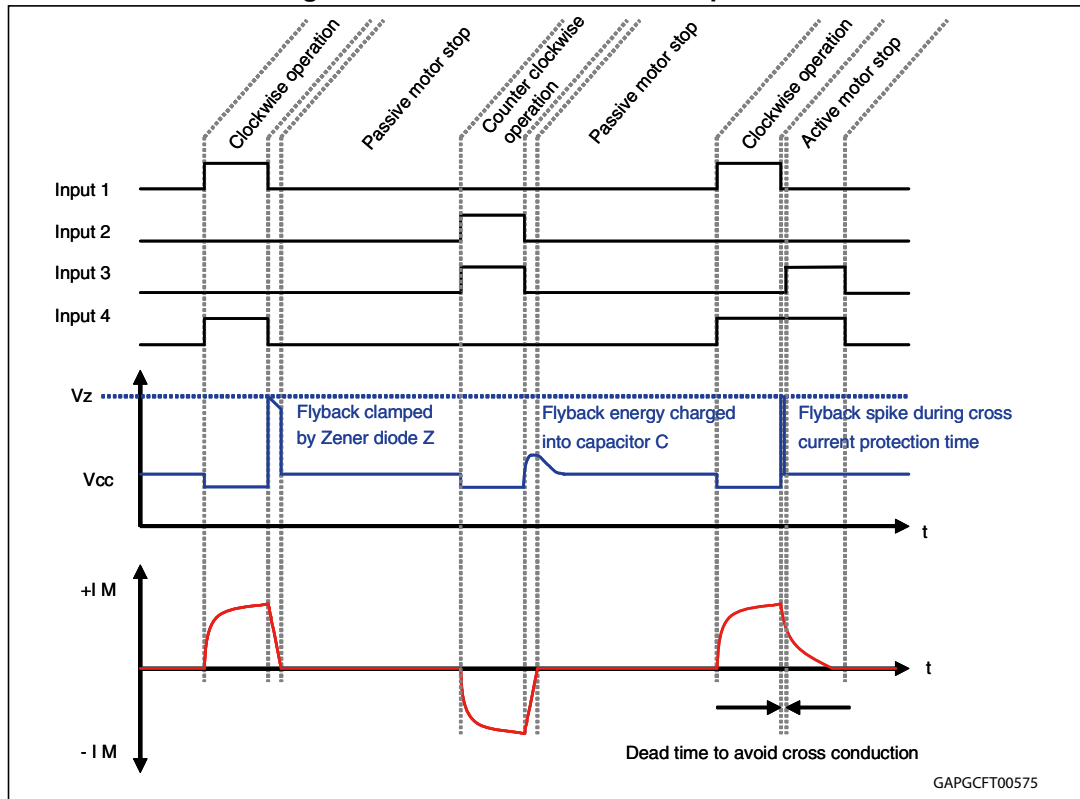
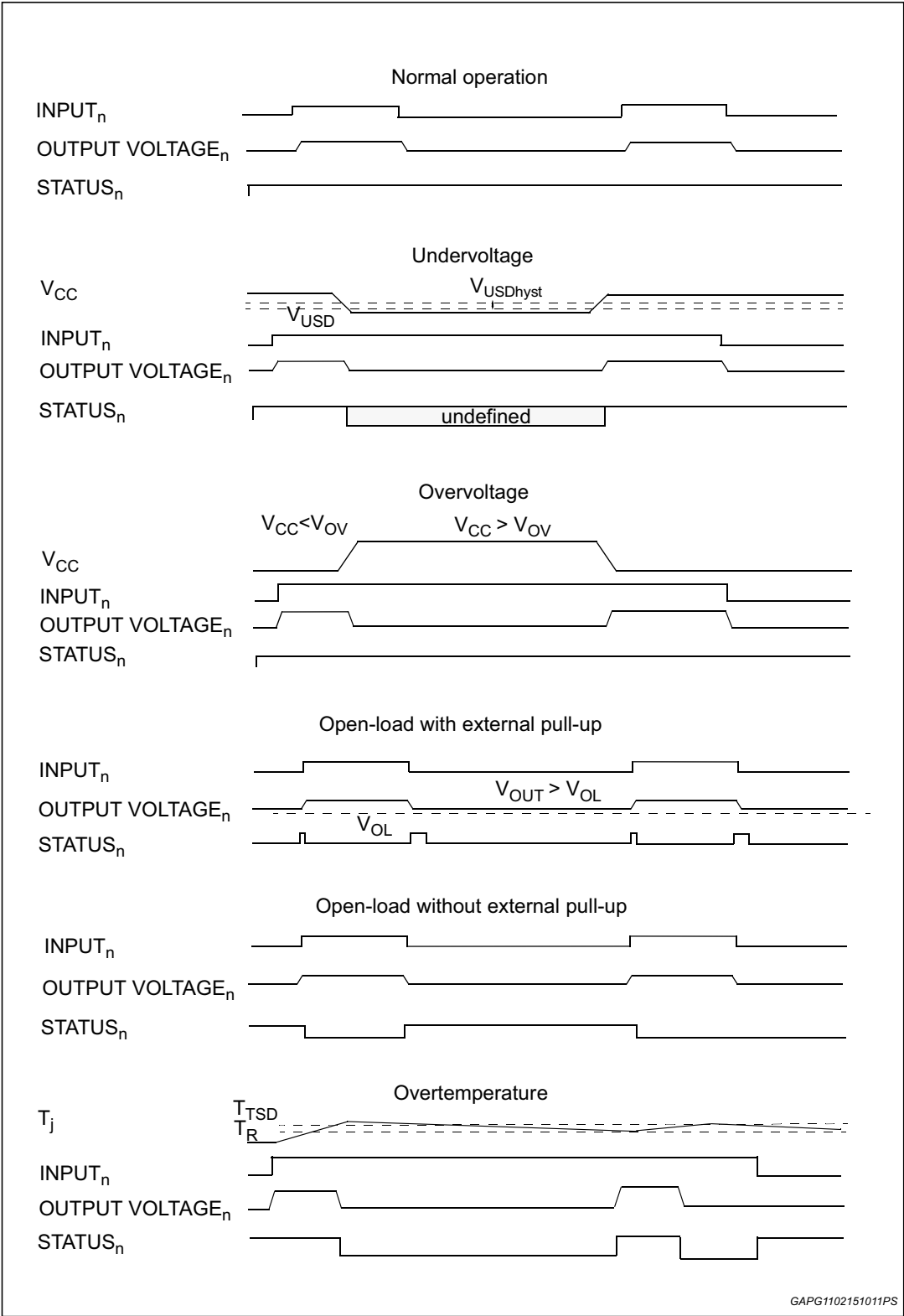


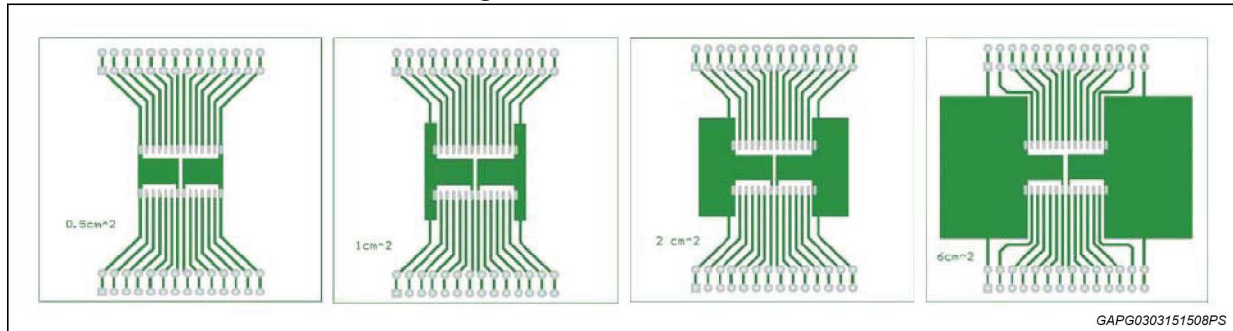
Figure 46. Waveforms



4 Thermal data

4.1 SO-28 thermal data

Figure 47. SO-28 PC board



Note: Layout condition of R_{th} and Z_{th} measurements (PCB FR4 area = 58 mm x 58 mm, PCB thickness = 2mm, Cu thickness = 35 μ m, Copper areas: from minimum pad layout to 6 cm²).

Figure 48. Chipset configuration

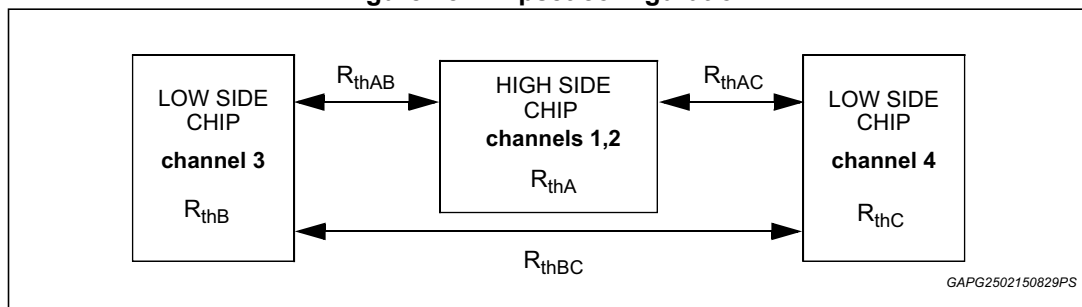
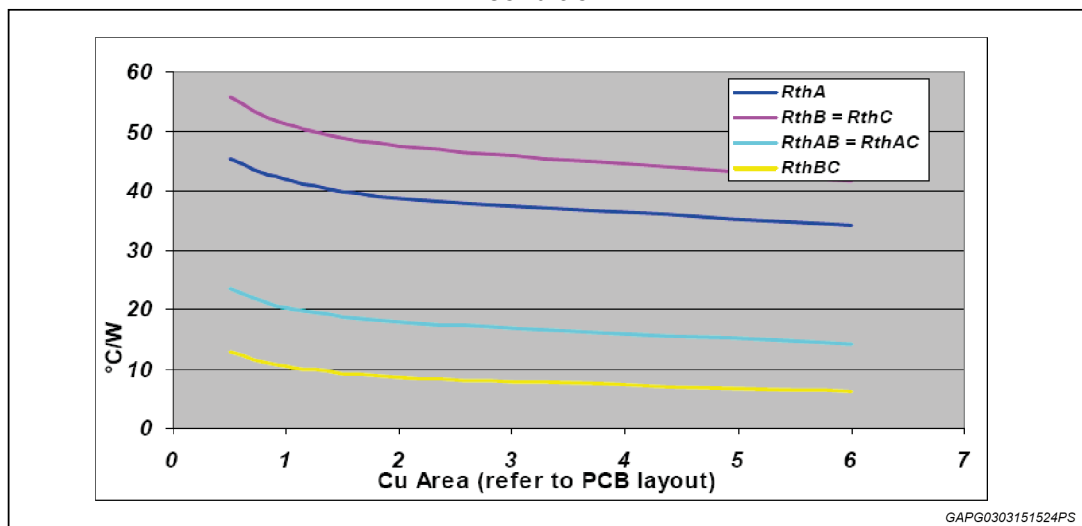


Figure 49. Auto and mutual $R_{thj-amb}$ vs PCB copper area in open box free air condition



Note: See definitions in Section 5.2 on page 31.

4.2 Thermal calculation in clockwise and anti-clockwise operation in steady state mode

Table 19. Thermal calculation in clockwise and anti-clockwise operation in steady state mode

HS ₁	HS ₂	LS ₃	LS ₄	T _{jHS12}	T _{jLS3}	T _{jLS4}
On	Off	Off	On	$\frac{P_{dHS1} \times R_{thHS} + P_{dLS4} \times R_{thHLSL}}{R_{thHLSL} + T_{amb}}$	$\frac{P_{dHS1} \times R_{thHLSL} + P_{dLS4} \times R_{thLSLS}}{R_{thLSLS} + T_{amb}}$	$\frac{P_{dHS1} \times R_{thHLSL} + P_{dLS4} \times R_{thLS}}{R_{thLS} + T_{amb}}$
Off	On	On	Off	$\frac{P_{dHS2} \times R_{thHS} + P_{dLS3} \times R_{thHLSL}}{R_{thHLSL} + T_{amb}}$	$\frac{P_{dHS2} \times R_{thHLSL} + P_{dLS3} \times R_{thLS}}{R_{thLS} + T_{amb}}$	$\frac{P_{dHS2} \times R_{thHLSL} + P_{dLS3} \times R_{thLSLS}}{R_{thLSLS} + T_{amb}}$

4.2.1 Thermal resistances definition

Values according to the PCB heatsink area.

$R_{thHS} = R_{thHS1} = R_{thHS2}$ = high side chip thermal resistance junction to ambient (HS₁ or HS₂ in on-state)

$R_{thLS} = R_{thLS3} = R_{thLS4}$ = low side chip thermal resistance junction to ambient

$R_{thHLSL} = R_{thHS1LS4} = R_{thHS2LS3}$ = mutual thermal resistance junction to ambient between high side and low side chips

$R_{thLSLS} = R_{thLS3LS4}$ = mutual thermal resistance junction to ambient between low side chips

4.2.2 Thermal calculation in transient mode

$$T_{jHS12} = Z_{thHS} \times P_{dHS12} + Z_{thHLSL} \times (P_{dLS3} + P_{dLS4}) + T_{amb}$$

$$T_{jLS3} = Z_{thHLSL} \times P_{dHS12} + Z_{thLS} \times P_{dLS3} + Z_{thLSLS} \times P_{dLS4} + T_{amb}$$

$$T_{jLS4} = Z_{thHLSL} \times P_{dHS12} + Z_{thLSLS} \times P_{dLS3} + Z_{thLS} \times P_{dLS4} + T_{amb}$$

Note: Calculation is valid in any dynamic operating condition. Pd values set by user.

4.2.3 Single pulse thermal impedance definition

Values according to the PCB heatsink area.

Z_{thHS} = high side chip thermal impedance junction to ambient

$Z_{thLS} = Z_{thLS3} = Z_{thLS4}$ = low side chip thermal impedance junction to ambient

$Z_{thHLSL} = Z_{thHS12LS3} = Z_{thHS12LS4}$ = mutual thermal impedance junction to ambient between high side and low side chips

$Z_{thLSLS} = Z_{thLS3LS4}$ = mutual thermal impedance junction to ambient between low side chips

4.2.4 Pulse calculation formula

$$Z_{TH\delta} = R_{TH} \cdot \delta + Z_{THtp}(1 - \delta)$$

where $\delta = t_p/T$

Figure 50. SO-28 HSD thermal impedance junction ambient single pulse

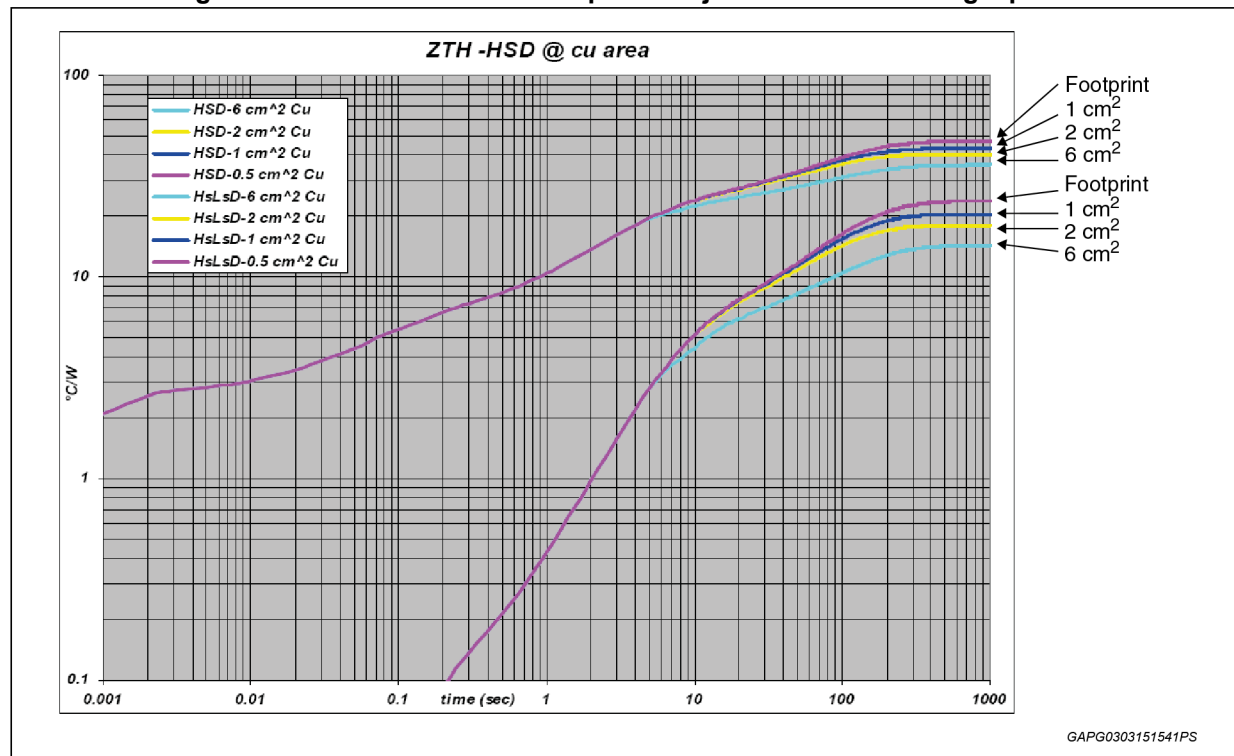


Figure 51. SO-28 LSD thermal impedance junction ambient single pulse

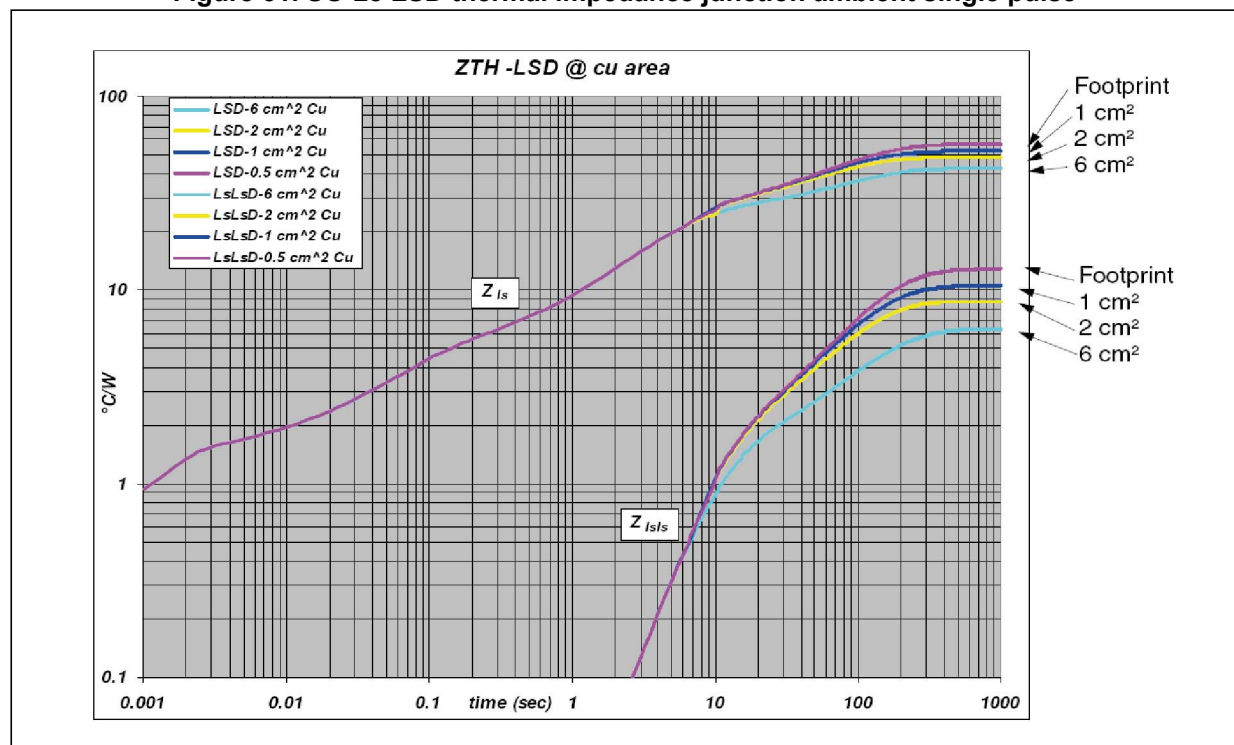


Figure 52. Thermal fitting model of an H-bridge in SO-28

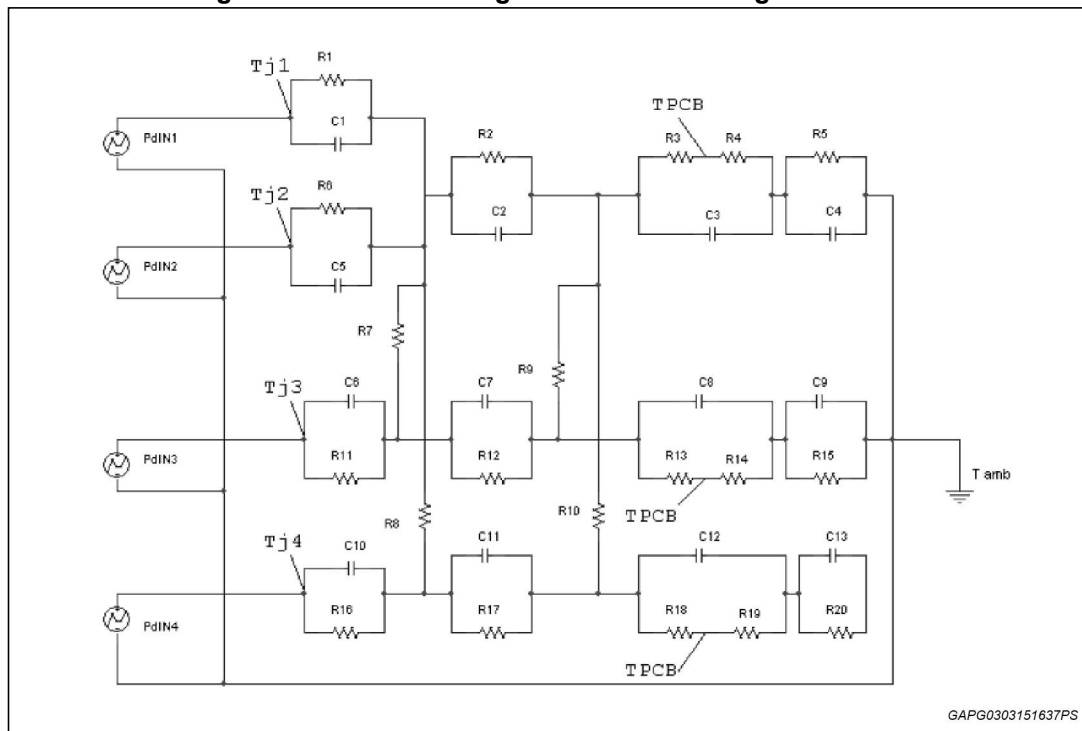


Table 20. Thermal parameters

Area/island (cm ²)	Footprint	1 ⁽¹⁾	2 ⁽¹⁾	6 ⁽¹⁾
R1 = R6 (°C/W)	2.6			
R2 (°C/W)	3.5			
R12 = R17 (°C/W)	3.5			
R3 = R13 = R18 (°C/W)	15.5			
R4 = R14 = R19 (°C/W)	10.5			
R5 = R15 = R20 (°C/W)	62.28	52.28	44.28	32.28
R7 = R8 = R9 = R10 (°C/W)	150			
R11 = R16 (°C/W)	1.5			
C1 = C5 (W.s/°C)	0.00025			
C2 = C7 = C11 (W.s/°C)	0.024			
C3 = C8 = C12 (W.s/°C)	0.2			
C4 = C9 = C13 (W.s/°C)	1.6	1.61	1.7	3.25
C6 = C10 (W.s/°C)	0.00075			

1. The blank space means that the value is the same as the previous one.

5 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com. ECOPACK® is an ST trademark.

5.1 SO-28 package information

Figure 53. SO-28 package outline

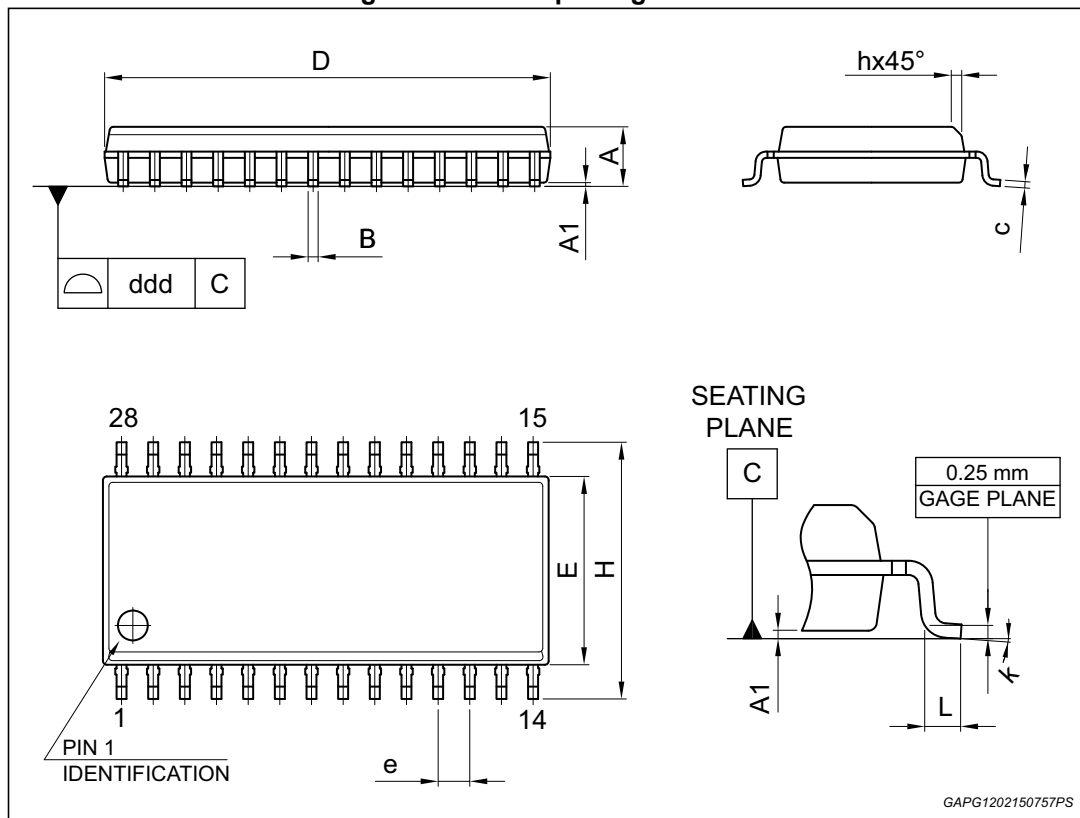


Table 21. SO-28 package mechanical data

Ref.	Dimensions		
	Millimeters		
	Min.	Typ.	Max.
A	2.35		2.65
A1	0.10		0.30
B	0.33		0.51
C	0.23		0.32
D ⁽¹⁾	17.70		18.10

Table 21. SO-28 package mechanical data

Ref.	Dimensions		
	Millimeters		
	Min.	Typ.	Max.
E	7.40		7.60
e		1.27	
H	10.0		10.65
h	0.25		0.75
L	0.40		1.27
k	0°		8°
ddd			0.10

1. Dimension "D" does not include mold flash, protrusions or gate burrs.
Mold flash, protrusions or gate burrs shall not exceed 0.15mm per side.

5.2 SO-28 packing information

Figure 54. SO-28 tube dimensions (no suffix)

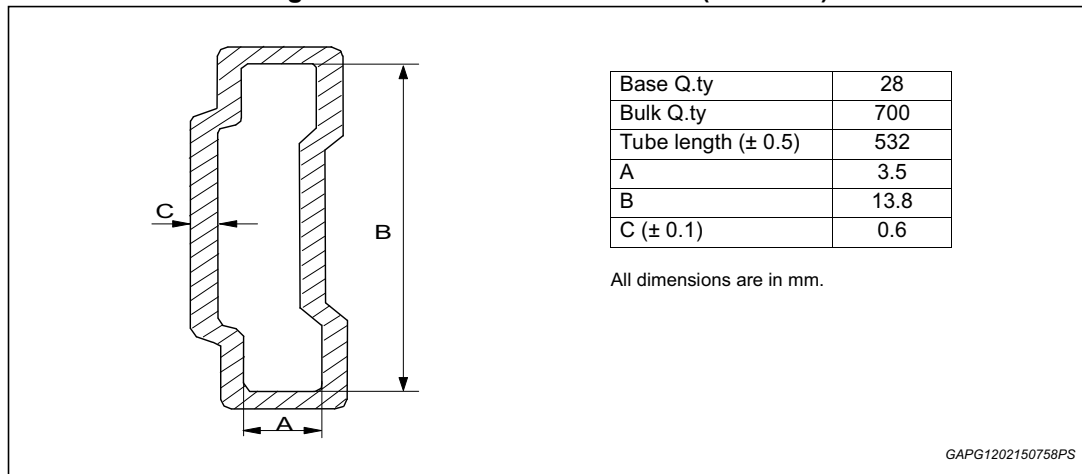
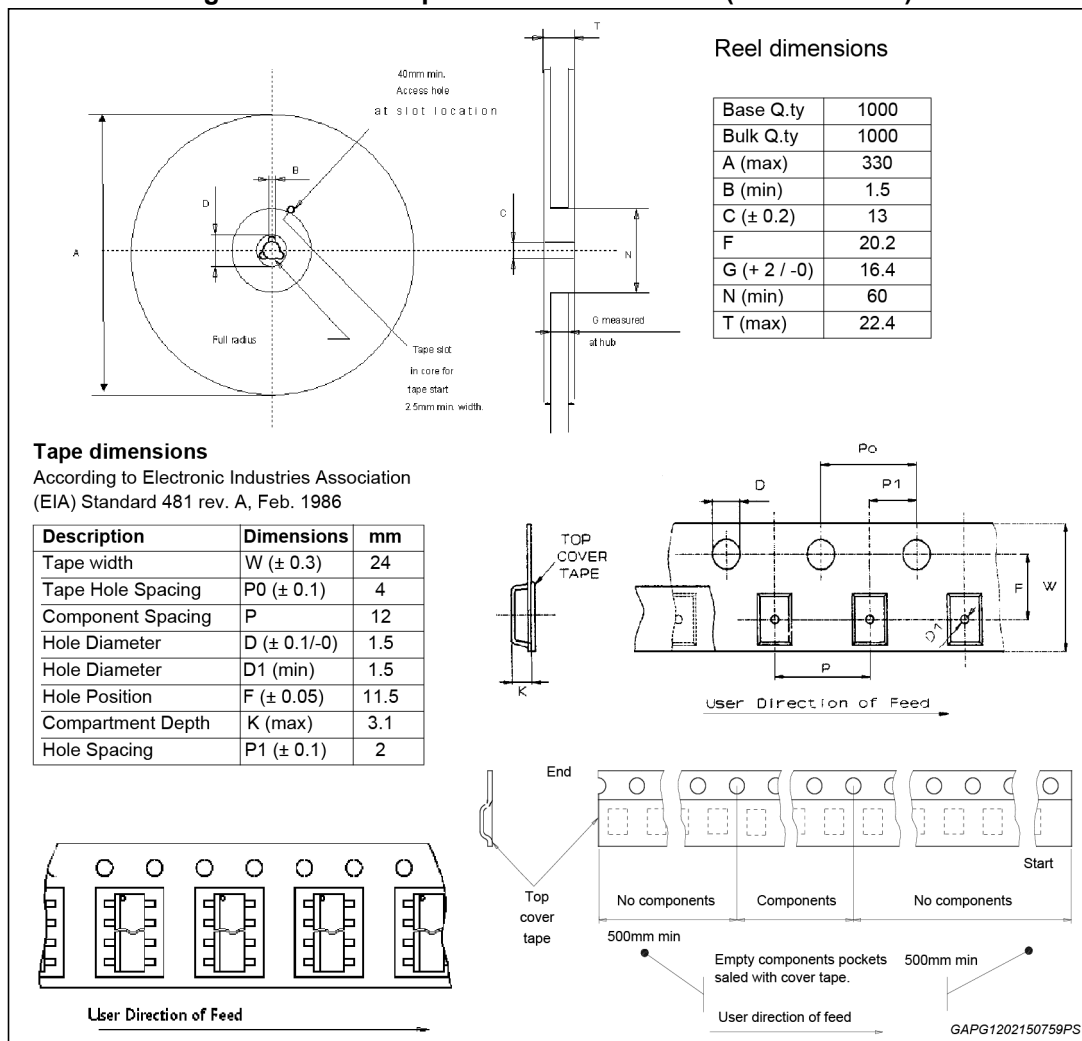


Figure 55. SO-28 tape and reel dimensions (suffix "13TR")



6 Revision history

Table 22. Document revision history

Date	Revision	Changes
20-Jul-2011	1	Initial release.
18-Sep-2013	2	Updated Disclaimer
04-Mar-2015	3	Updated: – Section 5.1: SO-28 package information ; – Tape dimensions in Figure 55: SO-28 tape and reel dimensions (suffix “13TR”) on page 31 .
12-Oct-2015	4	Updated pins name of the Figure 2 as defined in Table 2.

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